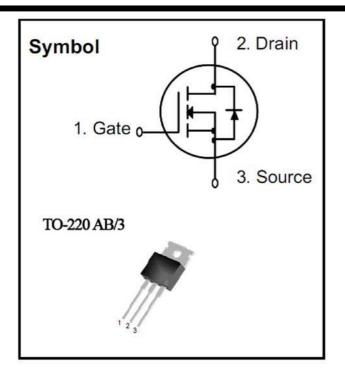


N-Channel MOSFET

Features

- R_{DS(on)} (Max 0.011 Ω)@V_{GS}=10V
- Gate Charge (Typical 80 nC)
- Maximum Junction Temperature Range (175 °C)



Absolute Maximum Ratings

Symbol	Parameter	Value	Units	
V _{DSS}	Drain to Source Voltage	80	V	
			<u> </u>	
I_{D}	Continuous Drain Current(@T _C = 25 °C)	80	A	
	Continuous Drain Current(@T _C = 100 °C)	75	Α	
I_{DM}	Drain Current Pulsed	3001)	Α	
V_{GS}	Gate to Source Voltage	±20	V	
E_AS	Single Pulsed Avalanche Energy	13102)	mJ	
E_{AR}	Repetitive Avalanche Energy	17 3 ¹⁾	mJ	
dv/dt	Peak Diode Recovery dv/dt	7 03)	V/ns	
P_{D}	Total Power Dissipation(@T _C = 25 °C)	173	W	
	Derating Factor above 25 °C	1.15	W/°C	
T_{STG}	Operating Junction Temperature	-55 ~ 175	°C	
TJ	Storage Temperature	150	°C	

Notes

^{1)...} Repeativity rating: pulse width limited by junction temperature

^{2)..} L = 0.32 mH, I_{AS} = 75 A, V_{DD} = 50 V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C

^{3)..} $I_{SD} \le 75$ A, di/dt ≤ 300 A/us, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25$ °C



Thermal Characteristics

Symbol	Parameter Value				Units	
		Min.	Тур.	Max.		
$R_{ heta JC}$	Thermal Resistance, Junction-to- Case	-	-	0.87	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to- Ambient*	-	0.5	-	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to- Ambient	-	-	62.5	°C/W	

^{*} When mounted on the minimum pad size recommended (PCB Mount)

Source-Drain Diode Characteristics and Maximum Ratings

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Is	Maximum Continuous Source-Drain Diode Forward Current		-	-	80	Α
I _{SM}	Maximum Pulsed Source-Drain Diode Forward Current			-	320	A
V_{SD}	Diode Forward Voltage	$I_S = 100 \text{ A}, V_{GS} = 0 \text{ V}$	-	-	1.5	V
t _{rr}	Reverse Recovery Time	$I_S = 100 \text{ A}, V_{GS} = 0 \text{ V},$ dIF/dt = 100 A/us	-	90	-	ns
Q _{rr}	Reverse Recovery Charge		-	250	-	uC

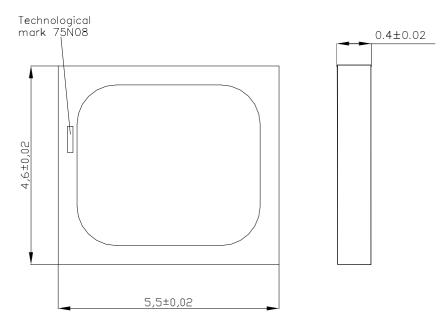


Electrical Characteristics ($T_C = 25$ °C unless otherwise noted)

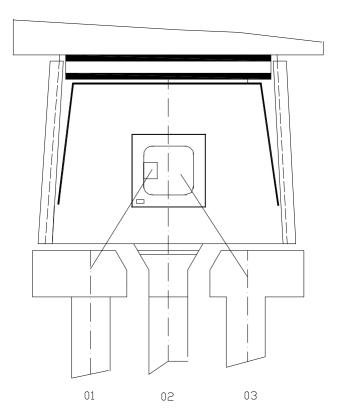
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
	cteristics					
BV _{DSS}	Drain-Source	$V_{GS} = 0 V$,	80	-	-	V
	Breakdown Voltage	$I_D = 250 \text{ uA}$				
ΔBV _{DSS} /	Breakdown Voltage	$I_D = 250 \text{ uA},$	-	0.08	-	V/°C
ΔTJ	Temperature coefficient	referenced to 25 °C				
I _{DSS}	Drain-Source Leakage Current	$V_{DS} = 80 \text{ V},$ $V_{GS} = 0 \text{ V}$	-	-	10	uA
	Carroni	$V_{DS} = 64 \text{ V},$ $T_{C} = 125 \text{ °C}$	-	-	100	uA
I _{GSS}	Gate-Source Leakage, Forward	$V_{GS} = 20 \text{ V},$ $V_{DS} = 0 \text{ V}$	-	-	100	nA
	Gate-source Leakage, Reverse	V _{GS} = -20 V, V _{DS} = 0 V	-	-	-100	nA
On Chara	cteristics		·	· I		
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \text{ uA}$	2.0	-	4.0	V
R _{DS(ON)}	Static Drain-Source On-state Resis-tance	V _{GS} = 10 V, I _D = 37.5 A	-	-	0.008	Ω
Dynamic	Characteristics	10 - 07.0 T				
C _{iss}	Input Capacitance		-	2600	3380	
Coss	Output Capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V},$	-	940	1220	_
C _{rss}	Reverse Transfer Capacitance	f = 1 MHz	-	210	275	pF
Dynamic	Characteristics		l .	·I		
t _{d(on)}	Turn-on Delay Time	$V_{DD} = 40 \text{ V},$	-	30	70	
t _r	Rise Time	$I_D = 100 \text{ A}, R_G = 25 \Omega$	-	225	460	no
t _{d(off)}	Turn-off Delay Time	Pulse Width ≤ 300us,	-	165	340	ns
t _f	Fall Time	Q > 50	-	155	320	
Qg	Total Gate Charge	V 64 V	-	80	105	
Q_{gs}	Gate-Source Charge	$V_{DS} = 64 \text{ V},$	-	15	-	nC
Q_{gd}	Gate-Drain Charge(Miller Charge)	$V_{GS} = 10 \text{ V},$ $I_{D} = 100 \text{ A}$	-	32	-	IIC



Chip size



Package Chip





Package Dimensions TO-220 AB/3

